

[REDACTED]

John L. Shew

2664

SEARCHED			
Class	Subclass	Date	Examiner
370	230	7/26/2005	JS
	351-356		
	389,401		
	410,465		
	466		
379	88.01	7/26/2005	JS
	121.04		
	207.02		
	219		
	221.06		
	221.15		
	227		
	265.03		
	265.09		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

[illegible]

**Search Notes (continued)**

Application/Control No.

09/771,992

Examiner

John L. Shew

Applicant(s)/Patent under  
Reexamination

SIEGRIST ET AL.

Art Unit

2664

**SEARCHED**

Class	Subclass	Date	Examiner
379	265.11	7/26/2005	JS
	388.07		
	390.01		
	420.03		
381	56,57	7/26/2005	JS
	58,60		
	82,83		
	92,93		
	94.5		
	94.8		
	94.9		
	95		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR